



A1N:16.XXJ

VOLTAGE RATINGS

Part Number	V _{RRM} , V _R (V)		V _{RSM} , V _R (V) Max. non-rep. peak reverse voltage
	Max. rep. peak reverse voltage	T _J = 0 to 125 °C	
A1N:16.02J	200	200	300
A1N:16.04J	400	400	500
A1N:16.06J	600	600	700
A1N:16.08J	800	800	900
A1N:16.10J	1000	1000	1100
A1N:16.12J	1200	1200	1300
A1N:16.14J	1400	1330	1500
A1N:16.16J	1600	1520	1700

This datasheet applies to:

Metric thread: A1N:16.XXJ

Inch thread: A2N:16.XXJ

MAXIMUM ALLOWABLE RATINGS

PARAMETER	VALUE	UNITS	NOTES
T _J Junction Temperature	-40 to 125	°C	-
T _{sg} Storage Temperature	-40 to 150	°C	-
I _{F(AV)} Max. Av. current @ Max. T _C	16 85	A °C	180° half sine wave
I _{F(RMS)} Nom. RMS current	35	A	-
I _{FSM} Max. Peak non-rep. surge current	0.28 0.31 0.33 0.36	A	50 Hz half cycle sine wave Initial T _J = 125°C, rated V _{RRM} applied after surge. 60 Hz half cycle sine wave 50 Hz half cycle sine wave Initial T _J = 125°C, no voltage applied after surge. 60 Hz half cycle sine wave
I ² t Max. I ² t capability	0.34 0.37 0.48 0.52	kA ² s	t = 10ms Initial T _J = 125°C, rated V _{RRM} applied after surge. t = 8.3 ms t = 10ms Initial T _J = 125°C, no voltage applied after surge. t = 8.3 ms
I ² t ^{1/2} Max. I ² t ^{1/2} capability	5.74	kA ² s ^{1/2}	Initial T _J = 125 C, no voltage applied after surge. I ² t for time t _x = I ² t ^{1/2} * t _x ^{1/2} . (0.1 < t _x < 10ms).
di/dt Max. Non-repetitive rate-of-rise current	150	A/ s	T _J = 125°C, V _D = V _{DRM} , I _{TM} = 1600A. Gate pulse: 20V, 20 , 10 s, 0.5 s rise time, Max. repetitive di/dt is approximately 40% of non-repetitive value.
P _G M Max. Peak gate power	8	W	tp < 5 ms
P _{G(AV)} Max. Av. gate power	2	W	-
+I _{GM} Max. Peak gate current	150	mA	tp < 5 ms
-V _{GM} Max. Peak negative gate voltage	2	V	-
F Mounting Force	2.8(25)	N.m(Lbf.in)	Non lubricated threads



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PARAMETER	MIN.	TYP.	MAX.	UNITS	TEST CONDITIONS
V_{TM} peak on-state voltage	---	---	1.84	V	Initial $T_J = 25^\circ\text{C}$, 50-60Hz half sine, $I_{\text{peak}} = 50\text{A}$.
$V_{T(\text{TO})}$ Threshold voltage	---	---	1	V	$T_J = 125^\circ\text{C}$ $\text{Av. power} = V_{T(\text{TO})} * I_{T(\text{AV})} + r_T * [I_{T(\text{RMS})}]^2$, 180° Half Sine.
r_T Slope resistance	---	---	18	m	Use low values for $I_{TM} <$ rated $I_{T(\text{AV})}$
I_L Latching current	---	---	200	mA	$T_C = 125^\circ\text{C}$, 12V anode. Gate pulse: 10V, 20 , 100 s.
I_H Holding current	---	---	100	mA	$T_C = 25^\circ\text{C}$, 12V anode. Initial $I_T = 15\text{A}$.
t_d Delay time	---	0.7	1.5	s	$T_C = 25^\circ\text{C}$, $V_D = V_{\text{DRM}}$, 50A resistive load. Gate pulse: 10V, 20 , 10 s, 1 s rise time.
t_q Turn-off time	---	125	200	s	$T_J = 125^\circ\text{C}$, $I_{TM} = 500\text{A}$, $\text{di}/\text{dt} = 25\text{A}/\text{s}$, $V_R = 50\text{V}$. $\text{dv}/\text{dt} = 20 \text{V}/\text{s}$ lin. to rated V_{DRM} . Gate: 0V, 100 .
dv/dt Critical rate-of-rise of off-state voltage	80	140	---	V/ s	$T_J = 125^\circ\text{C}$. Exp. to 100% or lin. Higher dv/dt values To 80% V_{DRM} , gate open. available.
	---	---	200		$T_J = 125^\circ\text{C}$, Exp. To 67% V_{DRM} , gate open.
I_{RM} , I_{DM} Peak reverse and off-state current	---	5	10	mA	$T_J = 125^\circ\text{C}$, Rated V_{RRM} and V_{DRM} , gate open.
I_{GT} DC gate current to trigger	---	---	300	mA	$T_C = -40^\circ\text{C}$
	50	80	150		$T_C = 25^\circ\text{C}$ +12V anode-to-cathode. For recommended
V_{GT} DC gate voltage to trigger	4	---	---	V	$T_C = -40^\circ\text{C}$ gate drive see "Gate Characteristics" figure.
	2	---	---		$T_C = 25^\circ\text{C}$
V_{GD} DC gate voltage not to trigger	---	---	0.2	V	$T_C = 25^\circ\text{C}$, Max. Value which will not trigger with rated V_{DRM} anode.
R_{thJC} Thermal resistance, junction-to-case	---	---	1.15	$^\circ\text{C}/\text{W}$	DC operation, single side cooled.
	---	---	1.3	$^\circ\text{C}/\text{W}$	180° sine wave, single side cooled.
	---	---	1.35	$^\circ\text{C}/\text{W}$	120° rectangular wave, single side cooled.
R_{thCS} Thermal resistance, case-to-sink	---	---	0.35	$^\circ\text{C}/\text{W}$	Mtg. Surface smooth, flat and greased. Single side cooled.
wt Weight	---	12(0.48)	---	g(oz.)	---
Case Style	TO-208AA (TO-48)		JEDEC		---

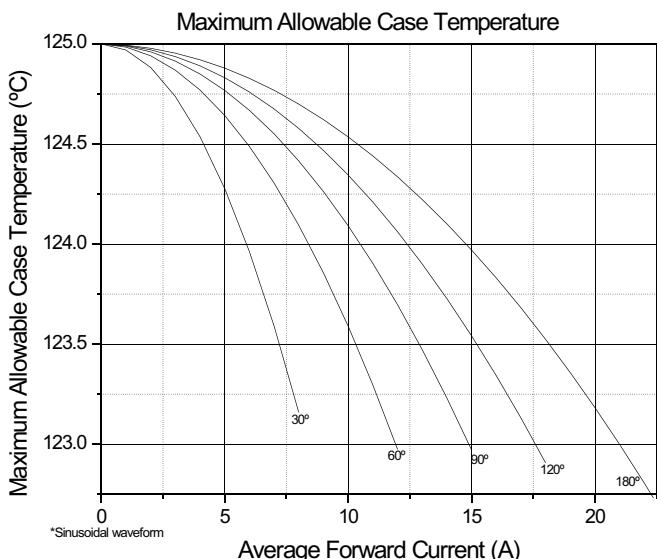


Fig. 1 - Current Ratings Characteristics

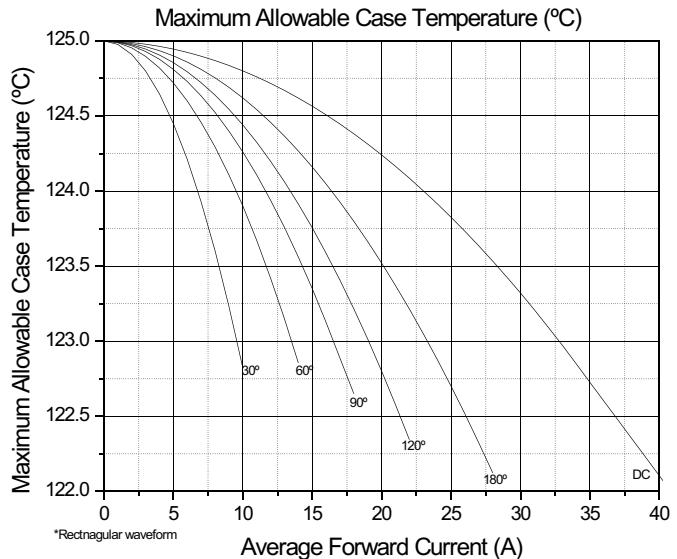


Fig. 2 - Current Ratings Characteristics



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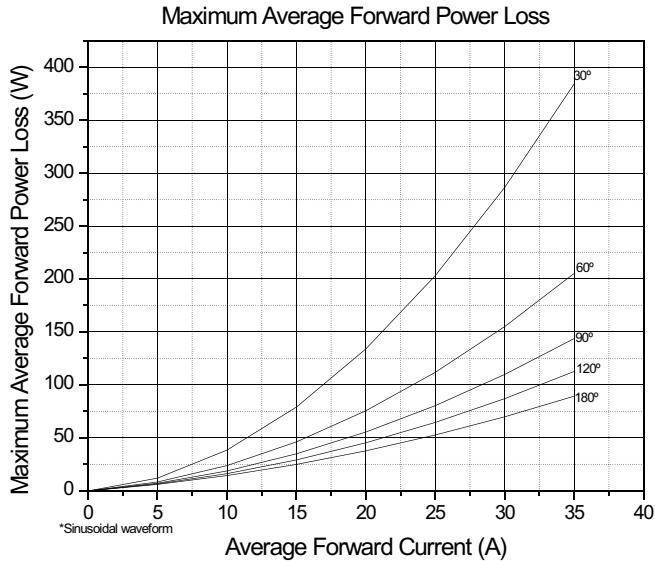


Fig. 3 - Forward Power Loss Characteristics

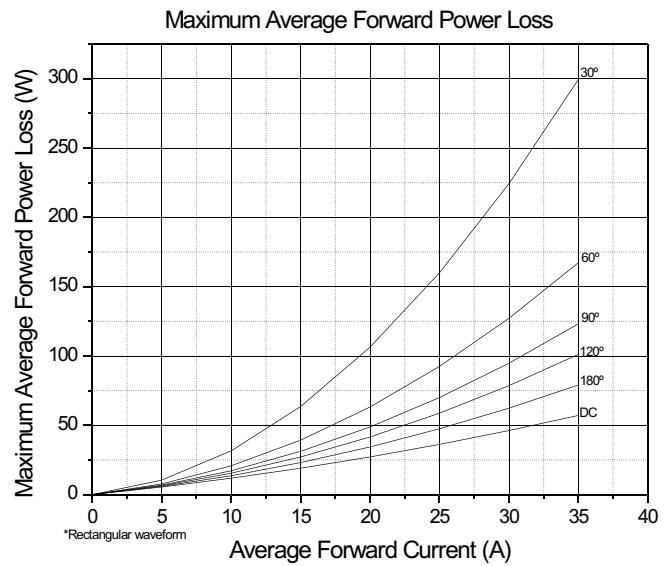


Fig. 4 - Forward Power Loss Characteristics

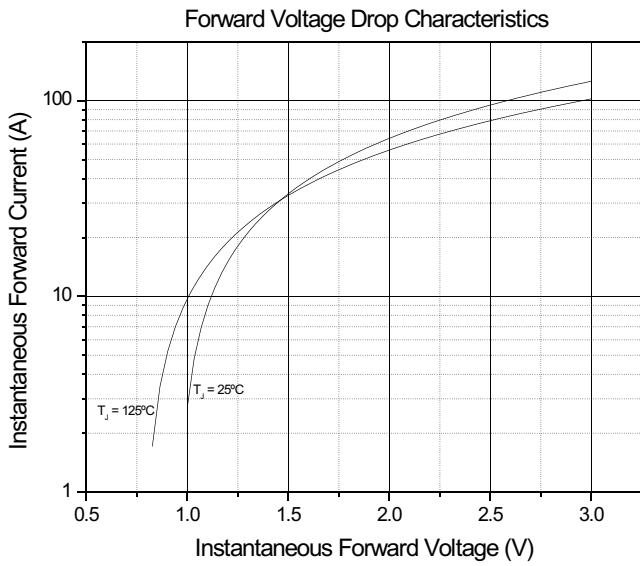


Fig. 5 - Forward Voltage Drop Characteristics

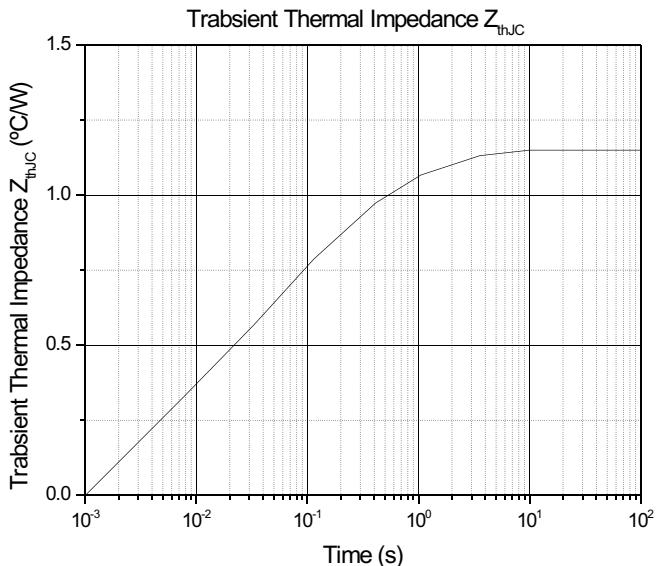


Fig. 6 - Transient Thermal Impedance Characteristics



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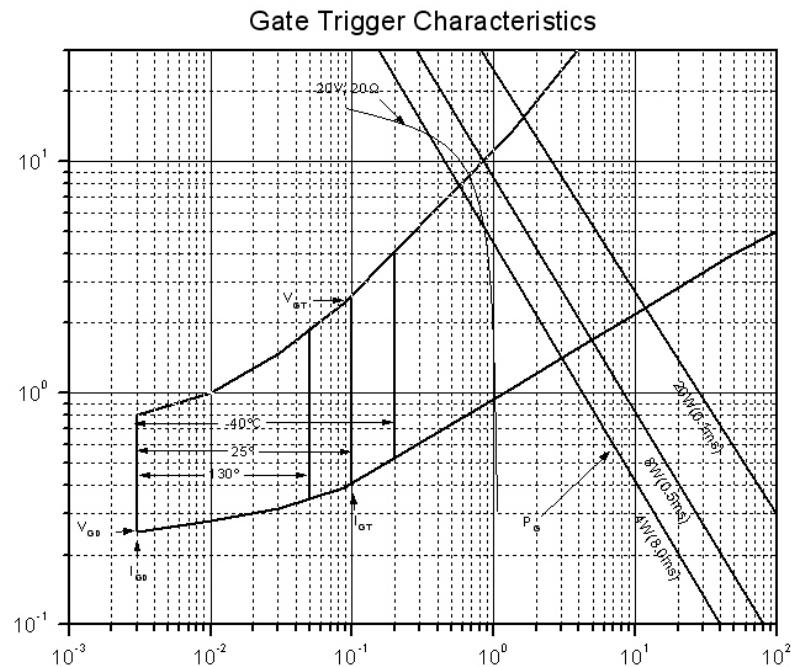


Fig. 7 - Gate Trigger Characteristics

TO-208AA (TO-48)

